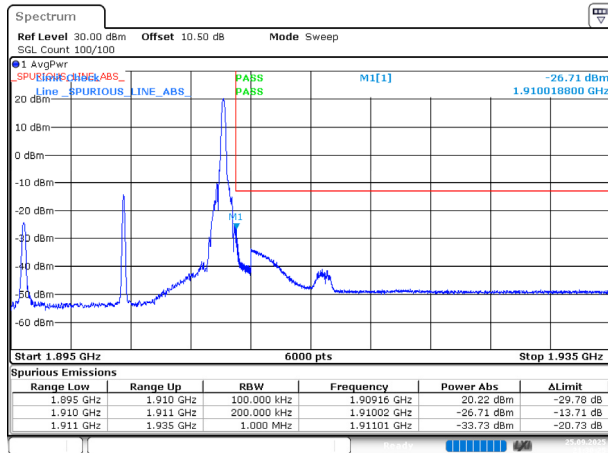
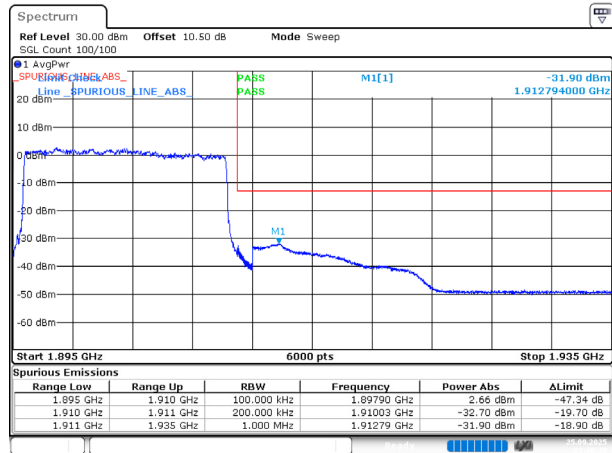


15MHz_High_QPSK_1@74



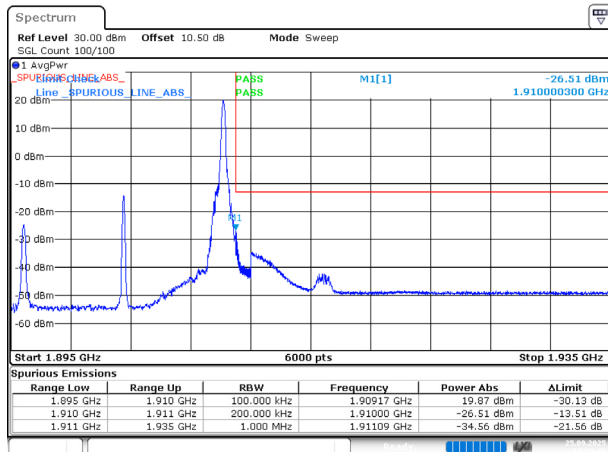
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:30:25

15MHz_High_QPSK_75@0



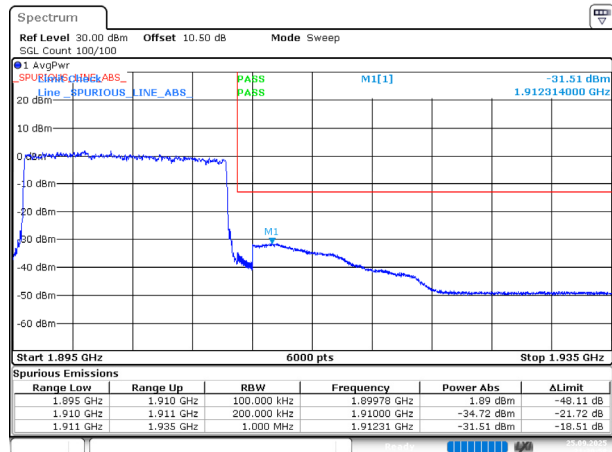
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:30:35

15MHz_High_16QAM_1@74



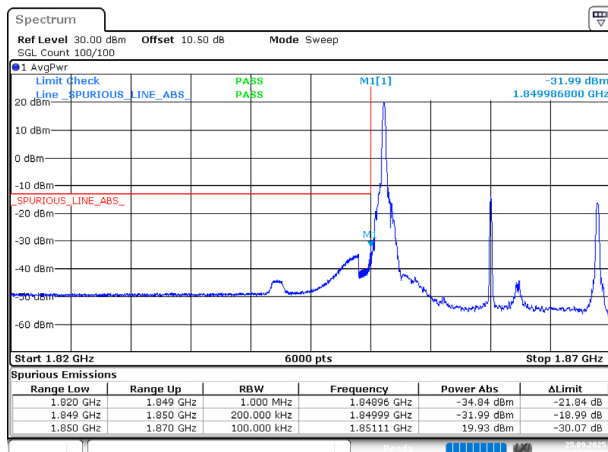
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:30:46

15MHz_High_16QAM_75@0



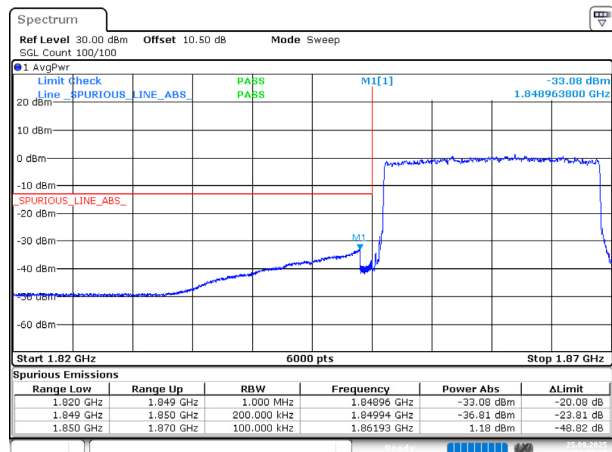
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:30:57

20MHz_Low_QPSK_1@0



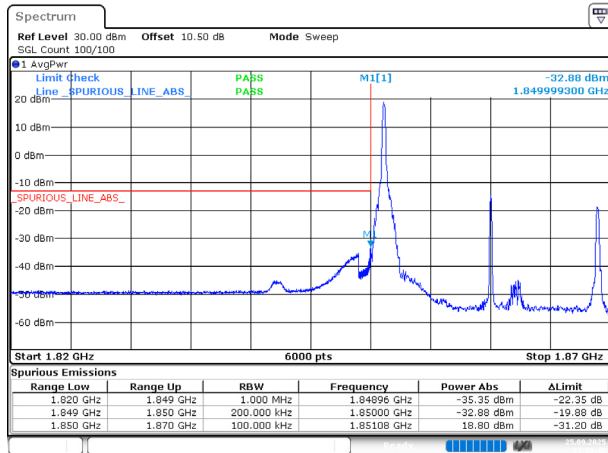
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:32:18

20MHz_Low_QPSK_100@0



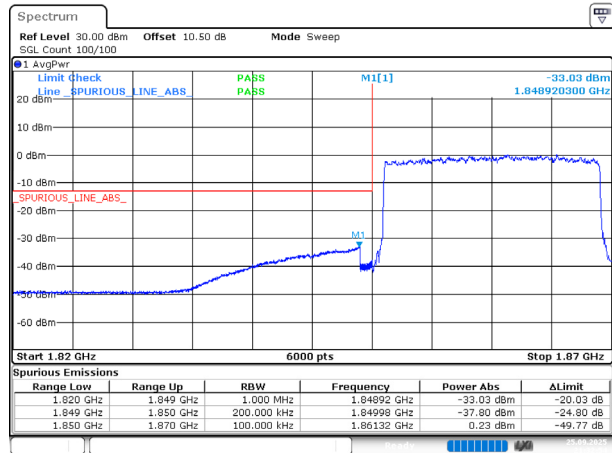
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:32:30

20MHz_Low_16QAM_1@0



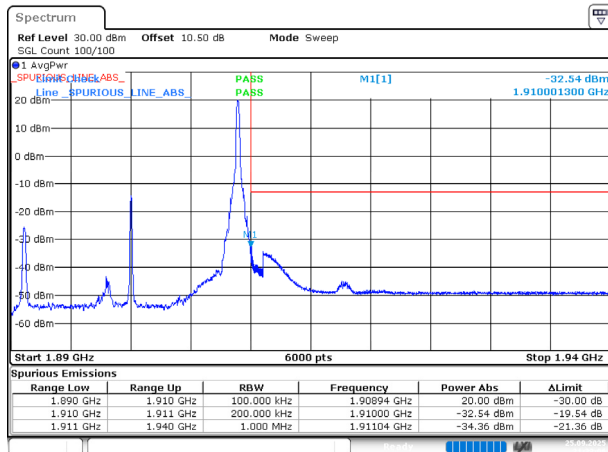
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:32:42

20MHz_Low_16QAM_100@0



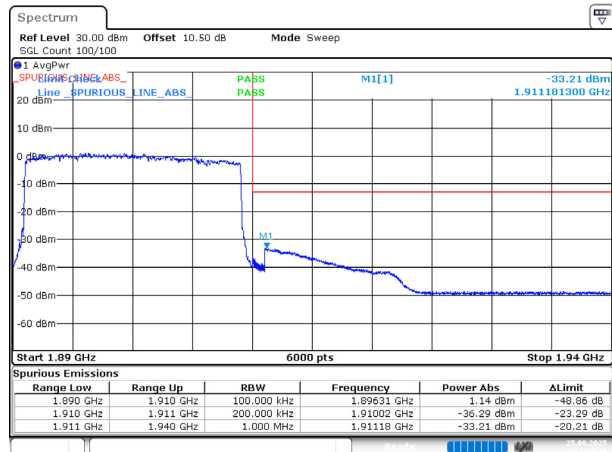
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:32:54

20MHz_High_QPSK_1@99



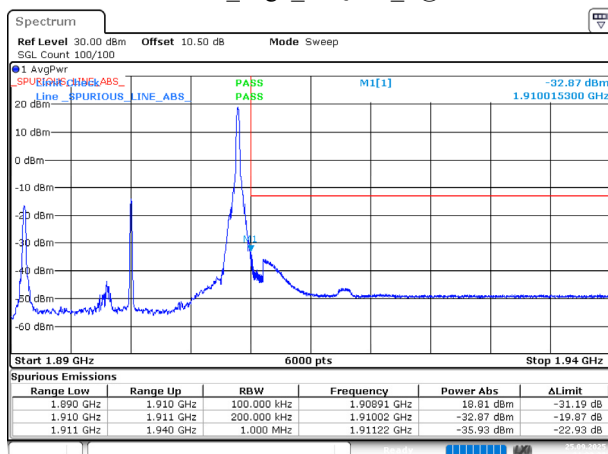
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:33:06

20MHz_High_QPSK_100@0



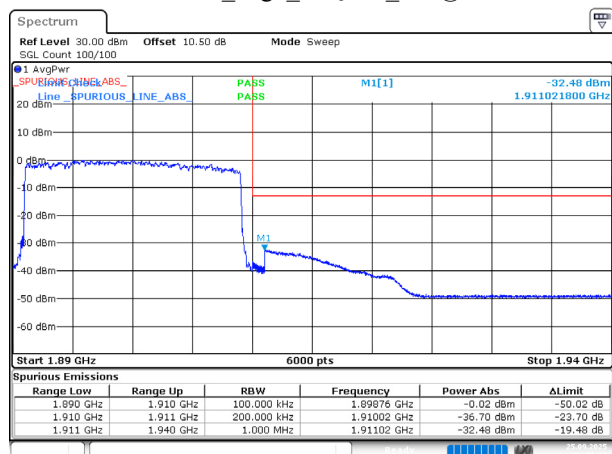
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:33:18

20MHz_High_16QAM_1@99



ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:33:30

20MHz_High_16QAM_100@0

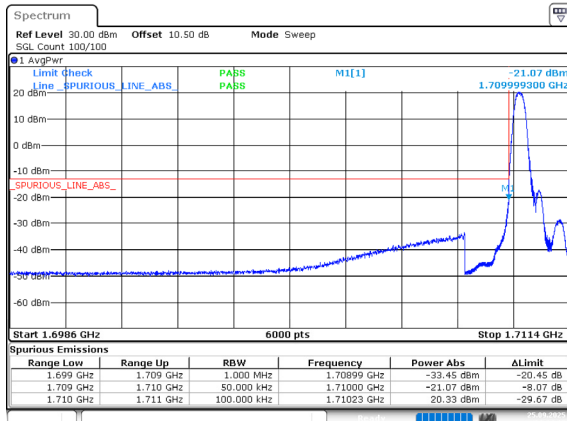


ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:33:42

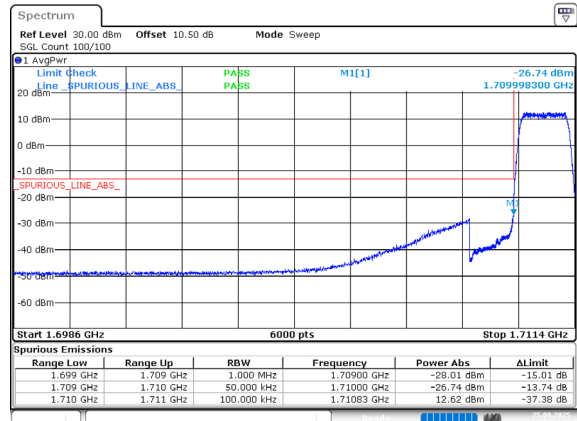
FCC Part 27

LTE Band 4, Normal

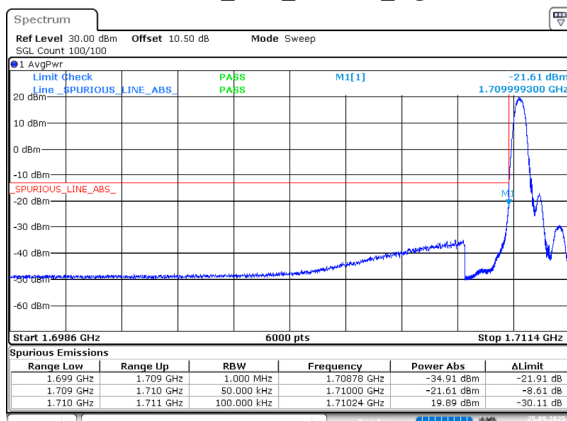
1.4MHz_Low_QPSK_1@0



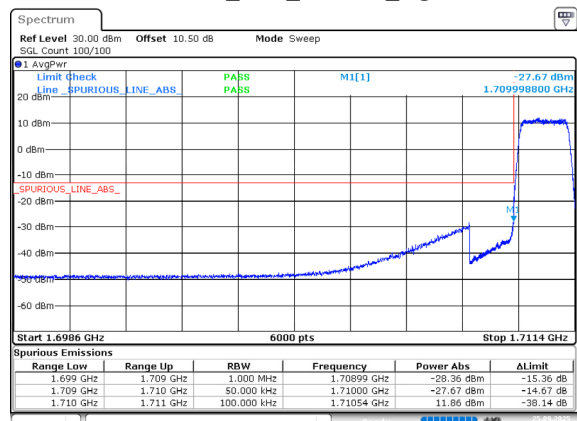
1.4MHz_Low_QPSK_6@0



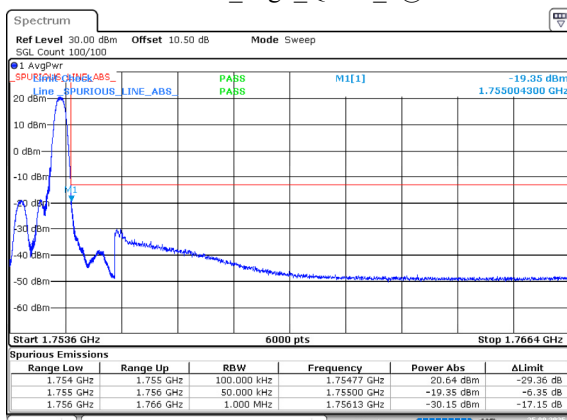
1.4MHz_Low_16QAM_1@0



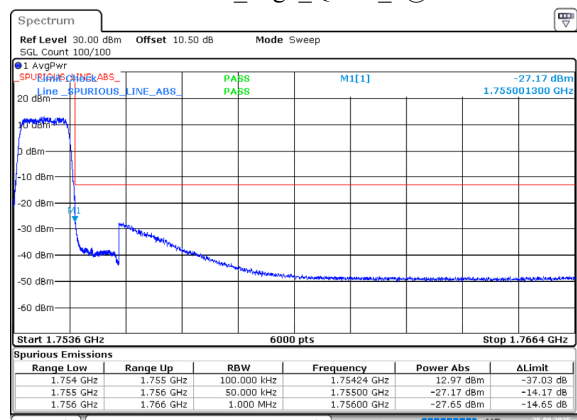
1.4MHz_Low_16QAM_6@0



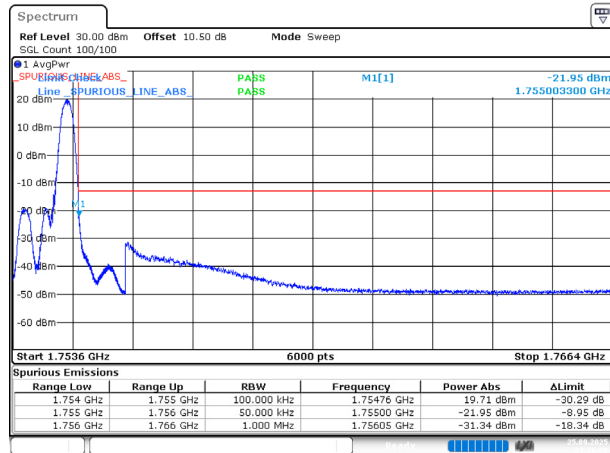
1.4MHz_High_QPSK_1@5



1.4MHz_High_QPSK_6@0

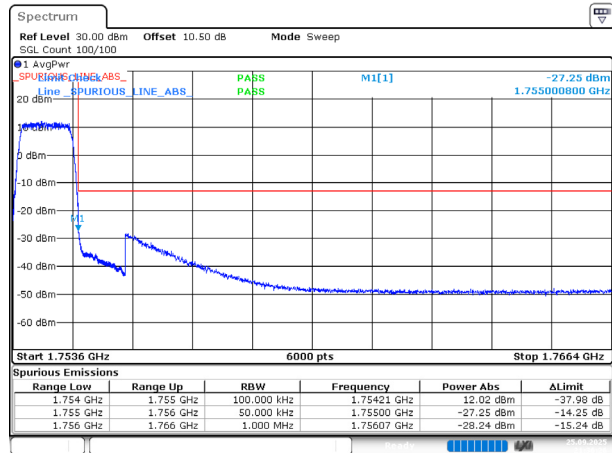


1.4MHz_High_16QAM_1@5



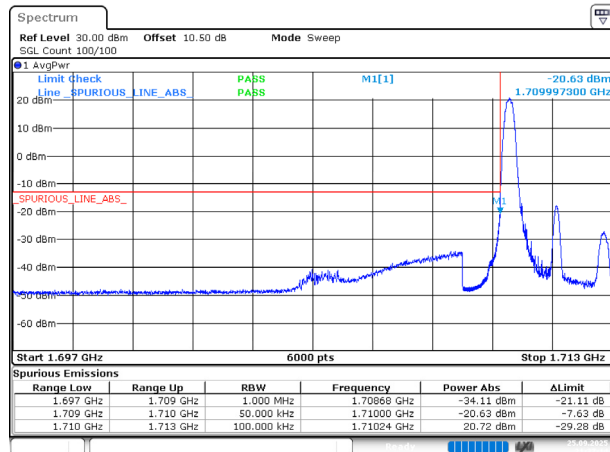
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:36:08

1.4MHz_High_16QAM_6@0



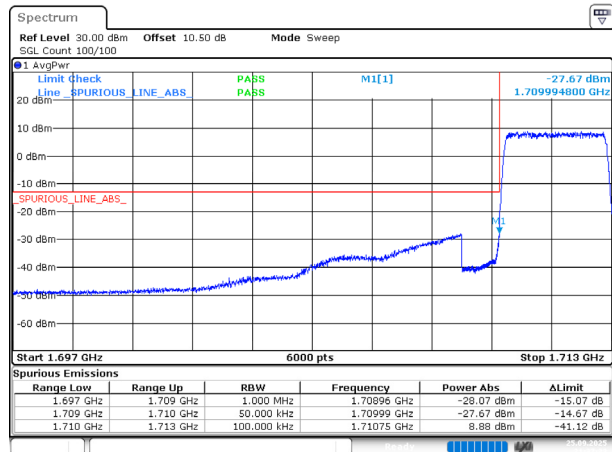
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:36:26

3MHz_Low_QPSK_1@0



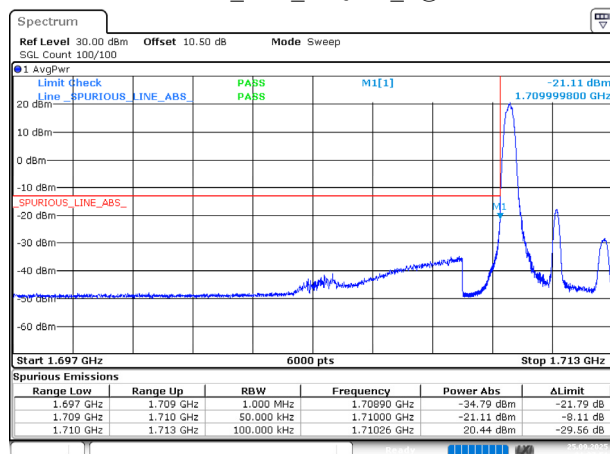
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:37:14

3MHz_Low_QPSK_15@0



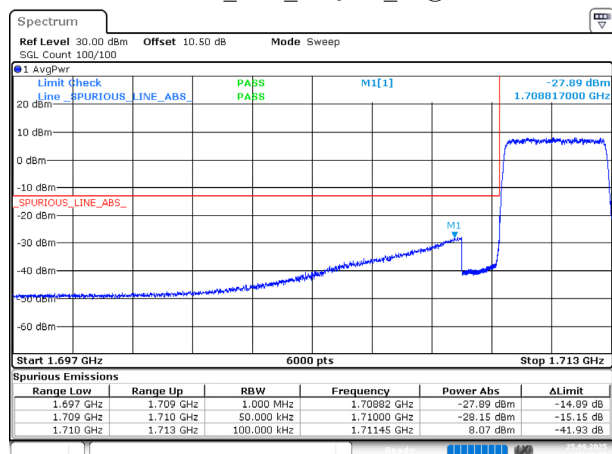
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:37:32

3MHz_Low_16QAM_1@0



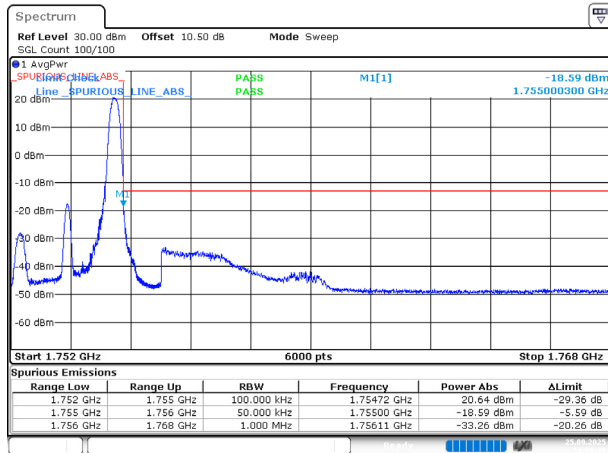
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:37:51

3MHz_Low_16QAM_15@0

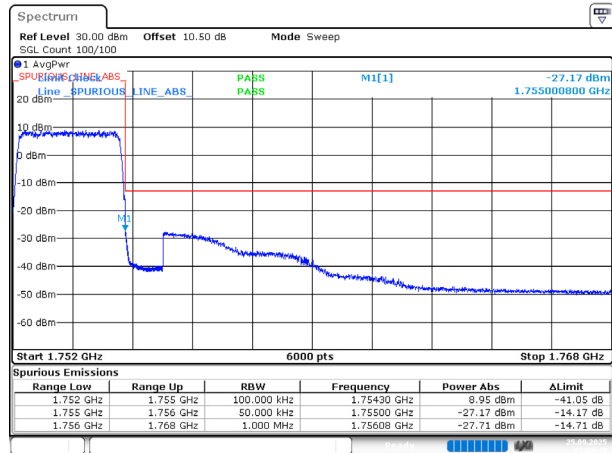


ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:38:10

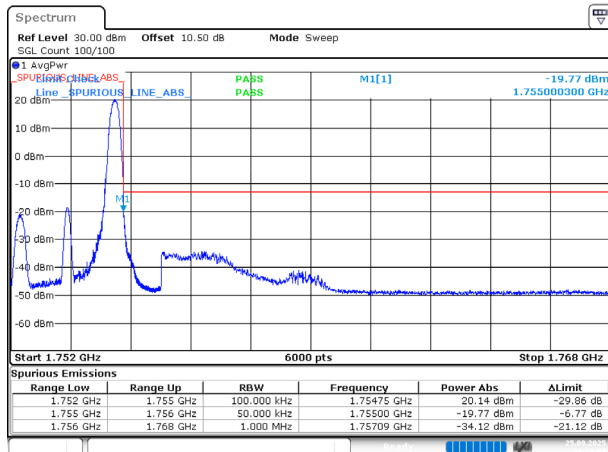
3MHz_High_QPSK_1@14



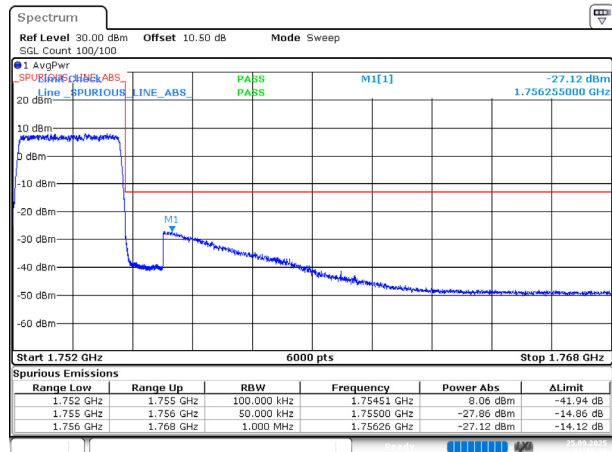
3MHz_High_QPSK_15@0



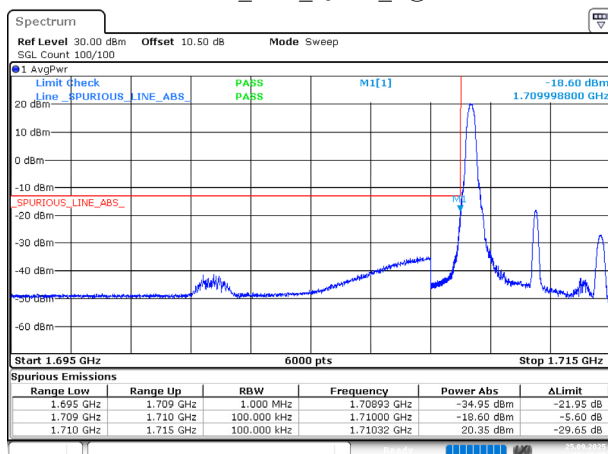
3MHz_High_16QAM_1@14



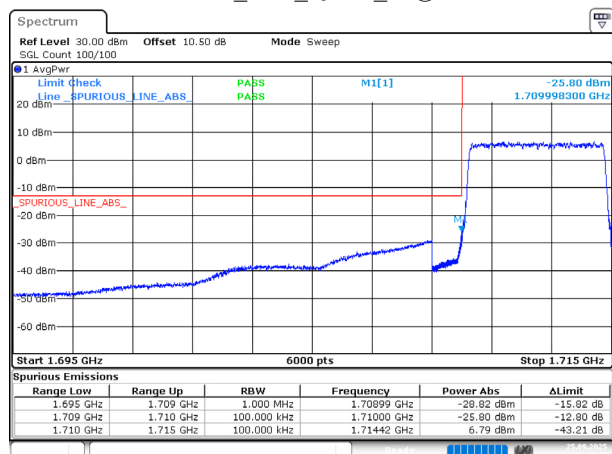
3MHz_High_16QAM_15@0



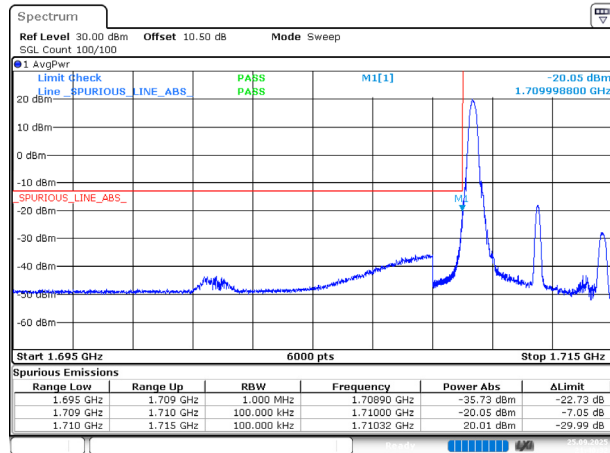
5MHz_Low_QPSK_1@0



5MHz_Low_QPSK_25@0

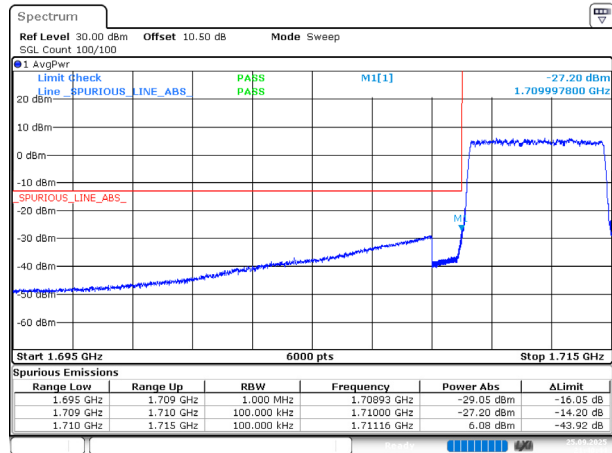


5MHz_Low_16QAM_1@0



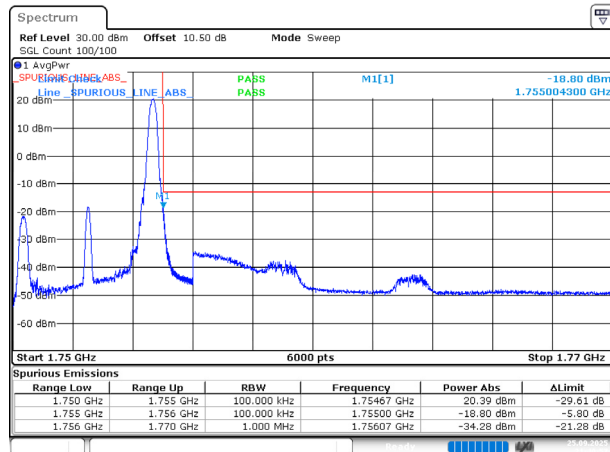
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:40:32

5MHz_Low_16QAM_25@0



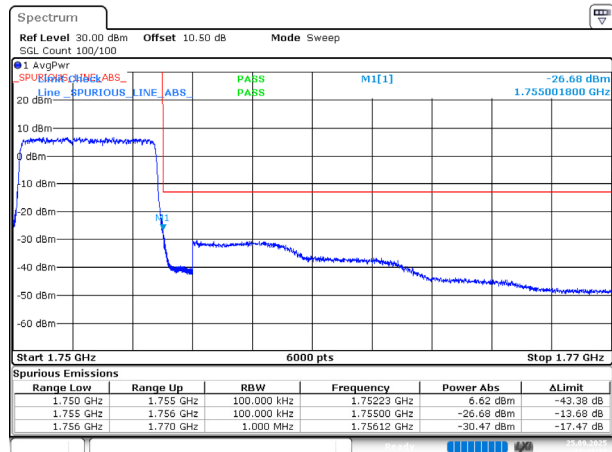
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:40:44

5MHz_High_QPSK_1@24



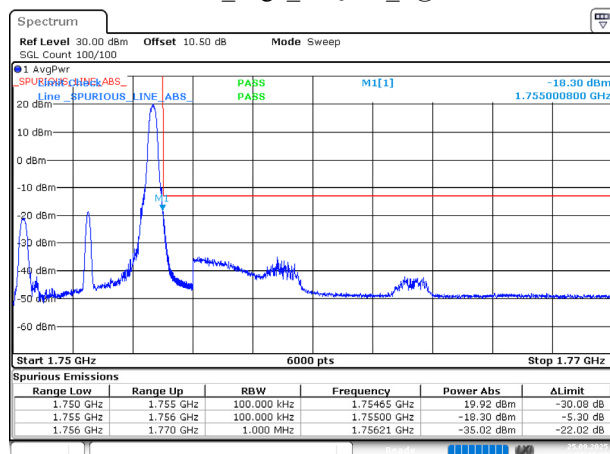
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:40:57

5MHz_High_QPSK_25@0



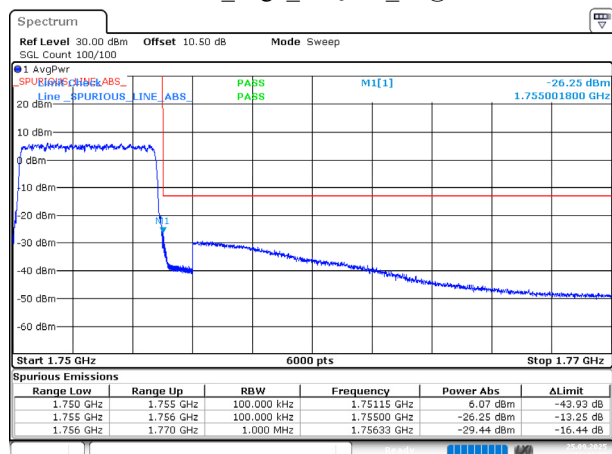
ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:41:10

5MHz_High_16QAM_1@24



ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:41:22

5MHz_High_16QAM_25@0



ProjectNo.:2501V00086E-RF Tester:Usain Ou
Date: 25.SEP.2025 21:41:35